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### Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

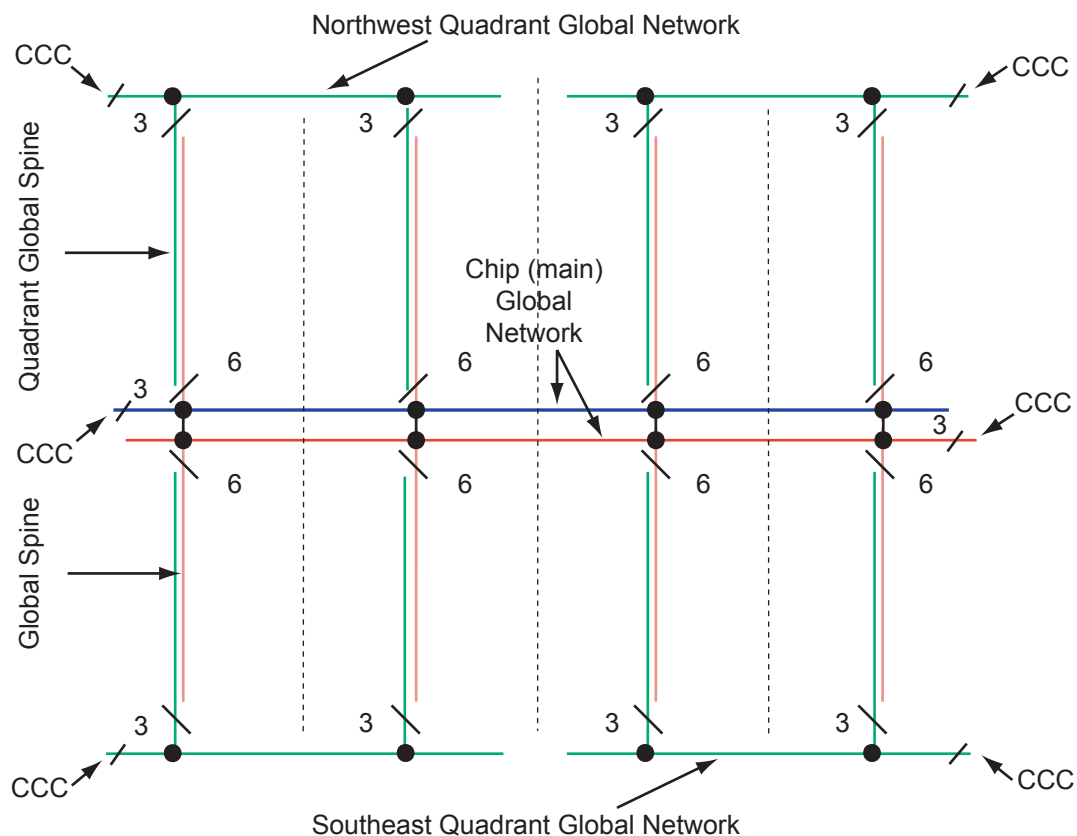
Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

#### Details

|                                |                                                                                                                                                                         |
|--------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Product Status                 | Active                                                                                                                                                                  |
| Number of LABs/CLBs            | -                                                                                                                                                                       |
| Number of Logic Elements/Cells | -                                                                                                                                                                       |
| Total RAM Bits                 | 276480                                                                                                                                                                  |
| Number of I/O                  | 252                                                                                                                                                                     |
| Number of Gates                | 1500000                                                                                                                                                                 |
| Voltage - Supply               | 1.425V ~ 1.575V                                                                                                                                                         |
| Mounting Type                  | Surface Mount                                                                                                                                                           |
| Operating Temperature          | -40°C ~ 100°C (TJ)                                                                                                                                                      |
| Package / Case                 | 676-BGA                                                                                                                                                                 |
| Supplier Device Package        | 676-FBGA (27x27)                                                                                                                                                        |
| Purchase URL                   | <a href="https://www.e-xfl.com/product-detail/microchip-technology/m1afs1500-2fgg676i">https://www.e-xfl.com/product-detail/microchip-technology/m1afs1500-2fgg676i</a> |



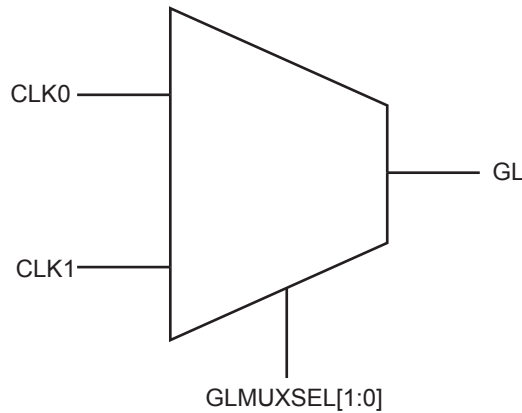
**Figure 2-12 • Global Network Architecture**

**Table 2-4 • Globals/Spines/Rows by Device**

|                                        | <b>AFS090</b> | <b>AFS250</b> | <b>AFS600</b> | <b>AFS1500</b> |
|----------------------------------------|---------------|---------------|---------------|----------------|
| Global VersaNets (trees)*              | 9             | 9             | 9             | 9              |
| VersaNet Spines/Tree                   | 4             | 8             | 12            | 20             |
| Total Spines                           | 36            | 72            | 108           | 180            |
| VersaTiles in Each Top or Bottom Spine | 384           | 768           | 1,152         | 1,920          |
| Total VersaTiles                       | 2,304         | 6,144         | 13,824        | 38,400         |

*Note:* \*There are six chip (main) globals and three globals per quadrant.

The NGMUX macro is simplified to show the two clock options that have been selected by the GLMUXCFG[1:0] bits. [Figure 2-25](#) illustrates the NGMUX macro. During design, the two clock sources are connected to CLK0 and CLK1 and are controlled by GLMUXSEL[1:0] to determine which signal is to be passed through the MUX.

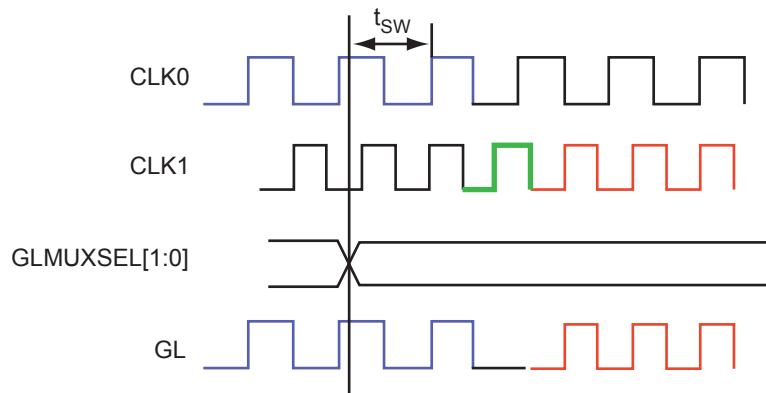


**Figure 2-25 • NGMUX Macro**

The sequence of switching between two clock sources (from CLK0 to CLK1) is as follows ([Figure 2-26](#)):

- GLMUXSEL[1:0] transitions to initiate a switch.
- GL drives one last complete CLK0 positive pulse (i.e., one rising edge followed by one falling edge).
- From that point, GL stays Low until the second rising edge of CLK1 occurs.
- At the second CLK1 rising edge, GL will begin to continuously deliver the CLK1 signal.
- Minimum  $t_{sw} = 0.05$  ns at 25°C (typical conditions)

For examples of NGMUX operation, refer to the [Fusion FPGA Fabric User Guide](#).



**Figure 2-26 • NGMUX Waveform**

The following error indications are possible for Read operations:

1. STATUS = '01' when a single-bit data error was detected and corrected within the block addressed.
2. STATUS = '10' when a double-bit error was detected in the block addressed (note that the error is uncorrected).

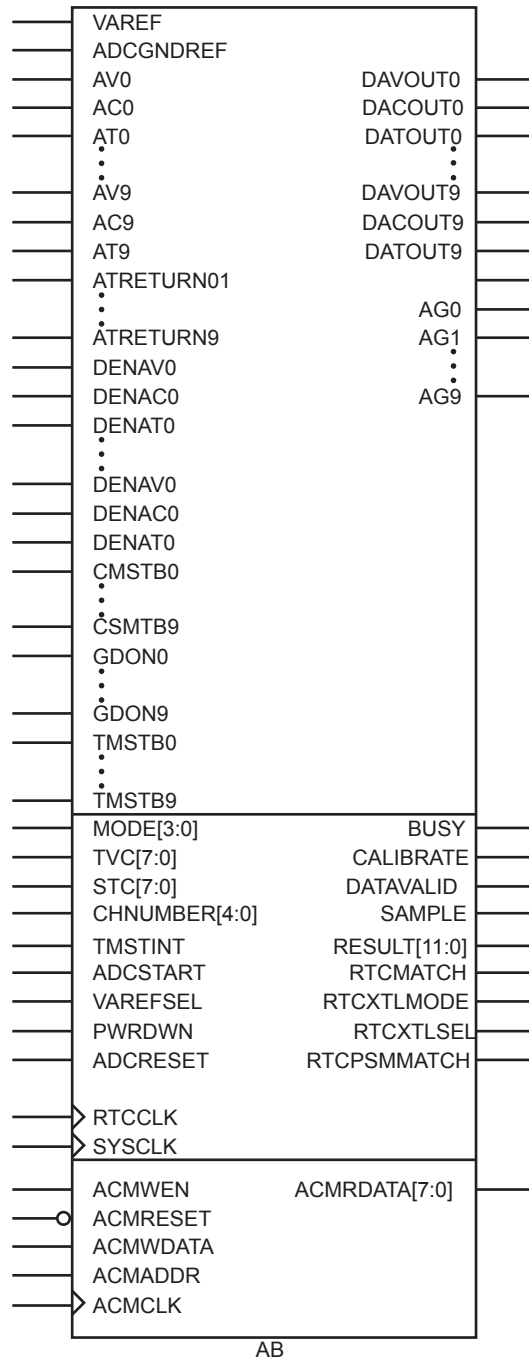
In addition to data reads, users can read the status of any page in the FB by asserting PAGESTATUS along with REN. The format of the data returned by a page status read is shown in [Table 2-23](#), and the definition of the page status bits is shown in [Table 2-24](#).

**Table 2-23 • Page Status Read Data Format**

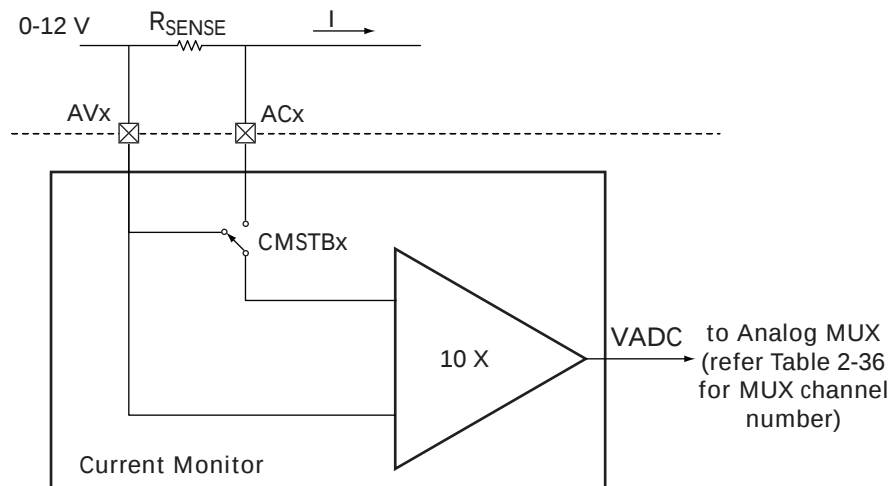
|             |   |          |   |                |                |                 |                     |
|-------------|---|----------|---|----------------|----------------|-----------------|---------------------|
| 31          | 8 | 7        | 4 | 3              | 2              | 1               | 0                   |
| Write Count |   | Reserved |   | Over Threshold | Read Protected | Write Protected | Overwrite Protected |

**Table 2-24 • Page Status Bit Definition**

| Page Status Bit(s) | Definition                                                                                                                                                                                                        |
|--------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 31–8               | The number of times the page addressed has been programmed/erased                                                                                                                                                 |
| 7–4                | Reserved; read as 0                                                                                                                                                                                               |
| 3                  | Over Threshold indicator (see the <a href="#">"Program Operation"</a> section on page 2-46)                                                                                                                       |
| 2                  | Read Protected; read protect bit for page, which is set via the JTAG interface and only affects JTAG operations. This bit can be overridden by using the correct user key value.                                  |
| 1                  | Write Protected; write protect bit for page, which is set via the JTAG interface and only affects JTAG operations. This bit can be overridden by using the correct user key value.                                |
| 0                  | Overwrite Protected; designates that the user has set the OVERWRITEPROTECT bit on the interface while doing a Program operation. The page cannot be written without first performing an Unprotect Page operation. |



**Figure 2-64 • Analog Block Macro**



**Figure 2-72 • Positive Current Monitor**

Care must be taken when choosing the right resistor for current measurement application. Note that because of the 10× amplification, the maximum measurable difference between the AV and AC pads is  $V_{AREF} / 10$ . A larger AV-to-AC voltage drop will result in ADC saturation; that is, the digital code put out by the ADC will stay fixed at the full scale value. Therefore, the user must select the external sense resistor appropriately. Table 2-38 shows recommended resistor values for different current measurement ranges. When choosing resistor values for a system, there is a trade-off between measurement accuracy and power consumption. Choosing a large resistor will increase the voltage drop and hence increase accuracy of the measurement; however the larger voltage drop dissipates more power ( $P = I^2 \times R$ ).

The Current Monitor is a unipolar system, meaning that the differential voltage swing must be from 0 V to  $V_{AREF}/10$ . Therefore, the Current Monitor only supports differential voltage where  $|V_{AV} - V_{AC}|$  is greater than 0 V. This results in the requirement that the potential of the AV pad must be larger than the potential of the AC pad. This is straightforward for positive voltage systems. For a negative voltage system, it means that the AV pad must be "more negative" than the AC pad. This is shown in Figure 2-73.

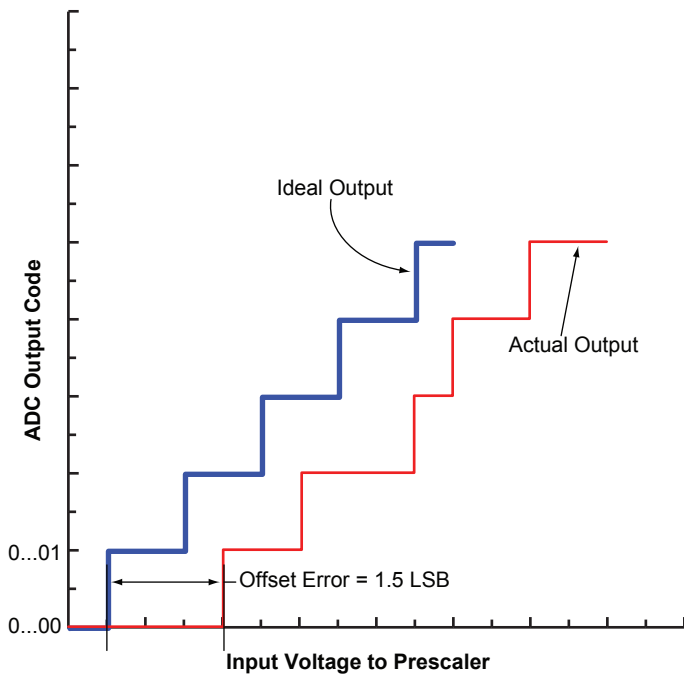
In this case, both the AV pad and the AC pad are configured for negative operations and the output of the differential amplifier still falls between 0 V and  $V_{AREF}$  as required.

**Table 2-37 • Recommended Resistor for Different Current Range Measurement**

| Current Range     | Recommended Minimum Resistor Value (Ohms) |
|-------------------|-------------------------------------------|
| > 5 mA – 10 mA    | 10 – 20                                   |
| > 10 mA – 20 mA   | 5 – 10                                    |
| > 20 mA – 50 mA   | 2.5 – 5                                   |
| > 50 mA – 100 mA  | 1 – 2                                     |
| > 100 mA – 200 mA | 0.5 – 1                                   |
| > 200 mA – 500 mA | 0.3 – 0.5                                 |
| > 500 mA – 1 A    | 0.1 – 0.2                                 |
| > 1 A – 2 A       | 0.05 – 0.1                                |
| > 2 A – 4 A       | 0.025 – 0.05                              |
| > 4 A – 8 A       | 0.0125 – 0.025                            |
| > 8 A – 12 A      | 0.00625 – 0.02                            |

### Offset Error

Offset error indicates how well the actual transfer function matches the ideal transfer function at a single point. For an ideal ADC, the first transition occurs at 0.5 LSB above zero. The offset voltage is measured by applying an analog input such that the ADC outputs all zeroes and increases until the first transition occurs (Figure 2-86).



**Figure 2-86 • Offset Error**

### Resolution

ADC resolution is the number of bits used to represent an analog input signal. To more accurately replicate the analog signal, resolution needs to be increased.

### Sampling Rate

Sampling rate or sample frequency, specified in samples per second (sps), is the rate at which an ADC acquires (samples) the analog input.

### SNR – Signal-to-Noise Ratio

SNR is the ratio of the amplitude of the desired signal to the amplitude of the noise signals at a given point in time. For a waveform perfectly reconstructed from digital samples, the theoretical maximum SNR (EQ 14) is the ratio of the full-scale analog input (RMS value) to the RMS quantization error (residual error). The ideal, theoretical minimum ADC noise is caused by quantization error only and results directly from the ADC's resolution (N bits):

$$SNR_{dB[Max]} = 6.02_{dB} \times N + 1.76_{dB}$$

EQ 14

### SINAD – Signal-to-Noise and Distortion

SINAD is the ratio of the rms amplitude to the mean value of the root-sum-square of the all other spectral components, including harmonics, but excluding DC. SINAD is a good indication of the overall dynamic performance of an ADC because it includes all components which make up noise and distortion.

### Total Harmonic Distortion

THD measures the distortion content of a signal, and is specified in decibels relative to the carrier (dBc). THD is the ratio of the RMS sum of the selected harmonics of the input signal to the fundamental itself. Only harmonics within the Nyquist limit are included in the measurement.

### ADC Input Multiplexer

At the input to the Fusion ADC is a 32:1 multiplexer. Of the 32 input channels, up to 30 are user definable. Two of these channels are hardwired internally. Channel 31 connects to an internal temperature diode so the temperature of the Fusion device itself can be monitored. Channel 0 is wired to the FPGA's 1.5 V VCC supply, enabling the Fusion device to monitor its own power supply. Doing this internally makes it unnecessary to use an analog I/O to support these functions. The balance of the MUX inputs are connected to Analog Quads (see the "Analog Quad" section on page 2-80). Table 2-40 defines which Analog Quad inputs are associated with which specific analog MUX channels. The number of Analog Quads present is device-dependent; refer to the family list in the "Fusion Family" table on page 1 of this datasheet for the number of quads per device. Regardless of the number of quads populated in a device, the internal connections to both VCC and the internal temperature diode remain on Channels 0 and 31, respectively. To sample the internal temperature monitor, it must be strobed (similar to the AT pads). The TMSTBINT pin on the Analog Block macro is the control for strobing the internal temperature measurement diode.

To determine which channel is selected for conversion, there is a five-pin interface on the Analog Block, CHNUMBER[4:0], defined in Table 2-39.

**Table 2-39 • Channel Selection**

| Channel Number | CHNUMBER[4:0] |
|----------------|---------------|
| 0              | 00000         |
| 1              | 00001         |
| 2              | 00010         |
| 3              | 00011         |
| ·              | ·             |
| ·              | ·             |
| ·              | ·             |
| 30             | 11110         |
| 31             | 11111         |

Table 2-40 shows the correlation between the analog MUX input channels and the analog input pins.

**Table 2-40 • Analog MUX Channels**

| Analog MUX Channel | Signal     | Analog Quad Number |
|--------------------|------------|--------------------|
| 0                  | Vcc_analog | Analog Quad 0      |
| 1                  | AV0        |                    |
| 2                  | AC0        |                    |
| 3                  | AT0        |                    |
| 4                  | AV1        | Analog Quad 1      |
| 5                  | AC1        |                    |
| 6                  | AT1        |                    |
| 7                  | AV2        | Analog Quad 2      |
| 8                  | AC2        |                    |
| 9                  | AT2        |                    |
| 10                 | AV3        | Analog Quad 3      |
| 11                 | AC3        |                    |
| 12                 | AT3        |                    |
| 13                 | AV4        | Analog Quad 4      |
| 14                 | AC4        |                    |
| 15                 | AT4        |                    |

### Integrated Voltage Reference

The Fusion device has an integrated on-chip 2.56 V reference voltage for the ADC. The value of this reference voltage was chosen to make the prescaling and postscaling factors for the prescaler blocks change in a binary fashion. However, if desired, an external reference voltage of up to 3.3 V can be connected between the VAREF and ADCGNDREF pins. The VAREFSEL control pin is used to select the reference voltage.

**Table 2-42 • VAREF Bit Function**

| Name  | Bit | Function                                                                                                                                                           |
|-------|-----|--------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| VAREF | 0   | Reference voltage selection<br>0 – Internal voltage reference selected. VAREF pin outputs 2.56 V.<br>1 – Input external voltage reference from VAREF and ADCGNDREF |

### ADC Clock

The speed of the ADC depends on its internal clock, ADCCLK, which is not accessible to users. The ADCCLK is derived from SYSCLK. Input signal TVC[7:0], Time Divider Control, determines the speed of the ADCCLK in relationship to SYSCLK, based on EQ 15.

$$t_{\text{ADCCLK}} = 4 \times (1 + \text{TVC}) \times t_{\text{SYSCLK}}$$

EQ 15

TVC: Time Divider Control (0–255)

$t_{\text{ADCCLK}}$  is the period of ADCCLK, and must be between 0.5 MHz and 10 MHz

$t_{\text{SYSCLK}}$  is the period of SYSCLK

**Table 2-43 • TVC Bits Function**

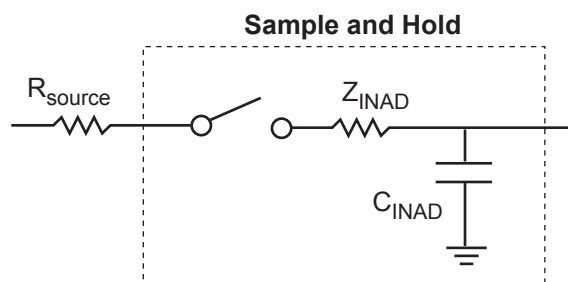
| Name | Bits  | Function               |
|------|-------|------------------------|
| TVC  | [7:0] | SYSCLK divider control |

The frequency of ADCCLK,  $f_{\text{ADCCLK}}$ , must be within 0.5 Hz to 10 MHz.

The inputs to the ADC are synchronized to SYSCLK. A conversion is initiated by asserting the ADCSTART signal on a rising edge of SYSCLK. Figure 2-90 on page 2-112 and Figure 2-91 on page 2-112 show the timing diagram for the ADC.

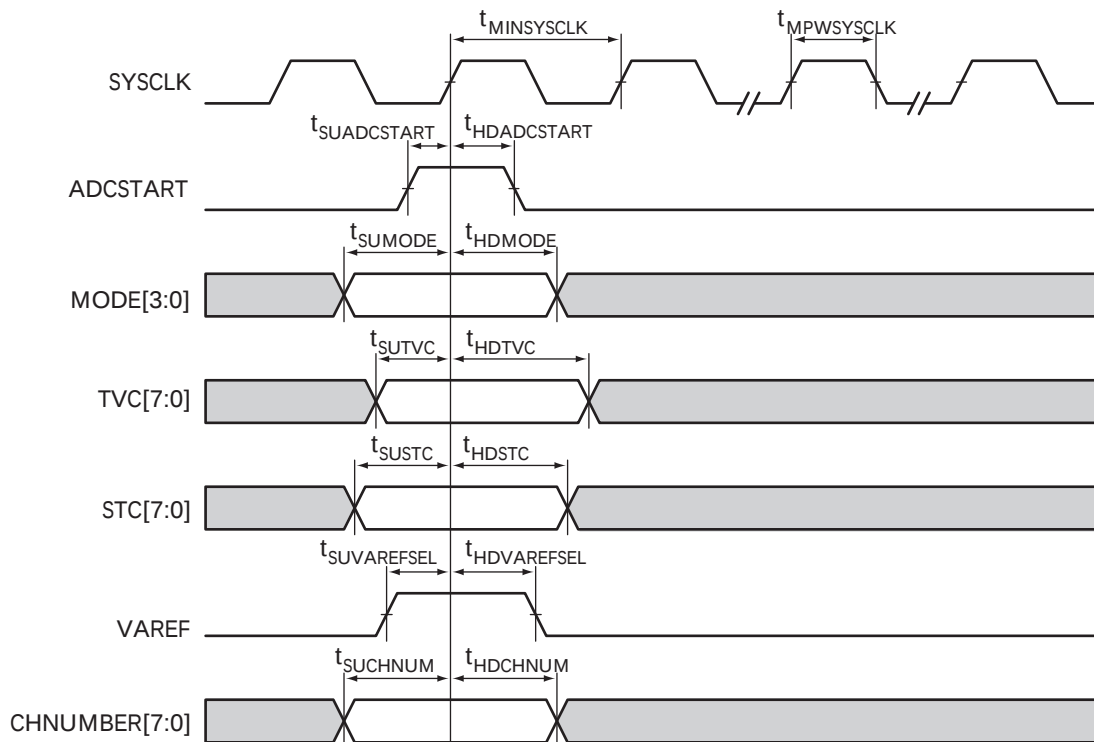
### Acquisition Time or Sample Time Control

Acquisition time ( $t_{\text{SAMPLE}}$ ) specifies how long an analog input signal has to charge the internal capacitor array. Figure 2-88 shows a simplified internal input sampling mechanism of a SAR ADC.



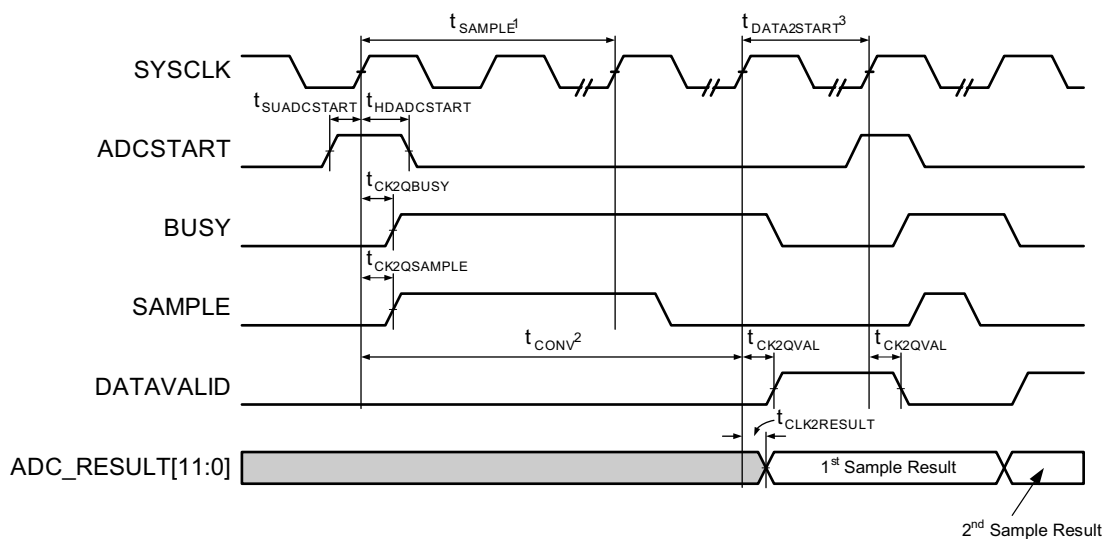
**Figure 2-88 • Simplified Sample and Hold Circuitry**

The internal impedance ( $Z_{\text{INAD}}$ ), external source resistance ( $R_{\text{SOURCE}}$ ), and sample capacitor ( $C_{\text{INAD}}$ ) form a simple RC network. As a result, the accuracy of the ADC can be affected if the ADC is given insufficient time to charge the capacitor. To resolve this problem, you can either reduce the source resistance or increase the sampling time by changing the acquisition time using the STC signal.



**Figure 2-90 • Input Setup Time**

**Standard Conversion**



**Notes:**

1. Refer to EQ 20 on page 2-109 for the calculation on the sample time,  $t_{SAMPLE}$ .
2. See EQ 23 on page 2-109 for calculation of the conversion time,  $t_{CONV}$ .
3. Minimum time to issue an ADCSTART after DATAVALID is 1 SYSCLK period

**Figure 2-91 • Standard Conversion Status Signal Timing Diagram**

### ADC Interface Timing

**Table 2-48 • ADC Interface Timing**  
 Commercial Temperature Range Conditions:  $T_J = 70^{\circ}\text{C}$ , Worst-Case  $V_{CC} = 1.425\text{ V}$

| Parameter                | Description                                    | -2     | -1     | Std.   | Units |
|--------------------------|------------------------------------------------|--------|--------|--------|-------|
| $t_{\text{SUMODE}}$      | Mode Pin Setup Time                            | 0.56   | 0.64   | 0.75   | ns    |
| $t_{\text{HDMODE}}$      | Mode Pin Hold Time                             | 0.26   | 0.29   | 0.34   | ns    |
| $t_{\text{SUTVC}}$       | Clock Divide Control (TVC) Setup Time          | 0.68   | 0.77   | 0.90   | ns    |
| $t_{\text{HDTVC}}$       | Clock Divide Control (TVC) Hold Time           | 0.32   | 0.36   | 0.43   | ns    |
| $t_{\text{SUSTC}}$       | Sample Time Control (STC) Setup Time           | 1.58   | 1.79   | 2.11   | ns    |
| $t_{\text{HDSTC}}$       | Sample Time Control (STC) Hold Time            | 1.27   | 1.45   | 1.71   | ns    |
| $t_{\text{SUVAREFSEL}}$  | Voltage Reference Select (VAREFSEL) Setup Time | 0.00   | 0.00   | 0.00   | ns    |
| $t_{\text{HDVAREFSEL}}$  | Voltage Reference Select (VAREFSEL) Hold Time  | 0.67   | 0.76   | 0.89   | ns    |
| $t_{\text{SUCHNUM}}$     | Channel Select (CHNUMBER) Setup Time           | 0.90   | 1.03   | 1.21   | ns    |
| $t_{\text{HDCHNUM}}$     | Channel Select (CHNUMBER) Hold Time            | 0.00   | 0.00   | 0.00   | ns    |
| $t_{\text{SUADCSTART}}$  | Start of Conversion (ADCSTART) Setup Time      | 0.75   | 0.85   | 1.00   | ns    |
| $t_{\text{HDADCSTART}}$  | Start of Conversion (ADCSTART) Hold Time       | 0.43   | 0.49   | 0.57   | ns    |
| $t_{\text{CK2QBUSY}}$    | Busy Clock-to-Q                                | 1.33   | 1.51   | 1.78   | ns    |
| $t_{\text{CK2QCAL}}$     | Power-Up Calibration Clock-to-Q                | 0.63   | 0.71   | 0.84   | ns    |
| $t_{\text{CK2QVAL}}$     | Valid Conversion Result Clock-to-Q             | 3.12   | 3.55   | 4.17   | ns    |
| $t_{\text{CK2QSAMPLE}}$  | Sample Clock-to-Q                              | 0.22   | 0.25   | 0.30   | ns    |
| $t_{\text{CK2QRESULT}}$  | Conversion Result Clock-to-Q                   | 2.53   | 2.89   | 3.39   | ns    |
| $t_{\text{CLR2QBUSY}}$   | Busy Clear-to-Q                                | 2.06   | 2.35   | 2.76   | ns    |
| $t_{\text{CLR2QCAL}}$    | Power-Up Calibration Clear-to-Q                | 2.15   | 2.45   | 2.88   | ns    |
| $t_{\text{CLR2QVAL}}$    | Valid Conversion Result Clear-to-Q             | 2.41   | 2.74   | 3.22   | ns    |
| $t_{\text{CLR2QSAMPLE}}$ | Sample Clear-to-Q                              | 2.17   | 2.48   | 2.91   | ns    |
| $t_{\text{CLR2QRESULT}}$ | Conversion result Clear-to-Q                   | 2.25   | 2.56   | 3.01   | ns    |
| $t_{\text{RECCLR}}$      | Recovery Time of Clear                         | 0.00   | 0.00   | 0.00   | ns    |
| $t_{\text{REMCLR}}$      | Removal Time of Clear                          | 0.63   | 0.72   | 0.84   | ns    |
| $t_{\text{MPWSYSCLK}}$   | Clock Minimum Pulse Width for the ADC          | 4.00   | 4.00   | 4.00   | ns    |
| $t_{\text{FMAXSYSCLK}}$  | Clock Maximum Frequency for the ADC            | 100.00 | 100.00 | 100.00 | MHz   |

**Table 2-50 • ADC Characteristics in Direct Input Mode (continued)**  
**Commercial Temperature Range Conditions,  $T_J = 85^\circ\text{C}$  (unless noted otherwise),**  
**Typical:  $V_{CC33A} = 3.3\text{ V}$ ,  $V_{CC} = 1.5\text{ V}$**

| Parameter                  | Description                | Condition   | Min. | Typ.  | Max.  | Units         |
|----------------------------|----------------------------|-------------|------|-------|-------|---------------|
| <b>Dynamic Performance</b> |                            |             |      |       |       |               |
| SNR                        | Signal-to-Noise Ratio      | 8-bit mode  | 48.0 | 49.5  |       | dB            |
|                            |                            | 10-bit mode | 58.0 | 60.0  |       | dB            |
|                            |                            | 12-bit mode | 62.9 | 64.5  |       | dB            |
| SINAD                      | Signal-to-Noise Distortion | 8-bit mode  | 47.6 | 49.5  |       | dB            |
|                            |                            | 10-bit mode | 57.4 | 59.8  |       | dB            |
|                            |                            | 12-bit mode | 62.0 | 64.2  |       | dB            |
| THD                        | Total Harmonic Distortion  | 8-bit mode  |      | -74.4 | -63.0 | dBc           |
|                            |                            | 10-bit mode |      | -78.3 | -63.0 | dBc           |
|                            |                            | 12-bit mode |      | -77.9 | -64.4 | dBc           |
| ENOB                       | Effective Number of Bits   | 8-bit mode  | 7.6  | 7.9   |       | bits          |
|                            |                            | 10-bit mode | 9.5  | 9.6   |       | bits          |
|                            |                            | 12-bit mode | 10.0 | 10.4  |       | bits          |
| <b>Conversion Rate</b>     |                            |             |      |       |       |               |
|                            | Conversion Time            | 8-bit mode  | 1.7  |       |       | $\mu\text{s}$ |
|                            |                            | 10-bit mode | 1.8  |       |       | $\mu\text{s}$ |
|                            |                            | 12-bit mode | 2    |       |       | $\mu\text{s}$ |
|                            | Sample Rate                | 8-bit mode  |      |       | 600   | Ksps          |
|                            |                            | 10-bit mode |      |       | 550   | Ksps          |
|                            |                            | 12-bit mode |      |       | 500   | Ksps          |

**Notes:**

1. Accuracy of the external reference is  $2.56\text{ V} \pm 4.6\text{ mV}$ .
2. Data is based on characterization.
3. The sample rate is time-shared among active analog inputs.

Table 2-57 details the settings available to control the prescaler values of the AV, AC, and AT pins. Note that the AT pin has a reduced number of available prescaler values.

**Table 2-57 • Prescaler Control Truth Table—AV (x = 0), AC (x = 1), and AT (x = 3)**

| Control Lines Bx[2:0] | Scaling Factor, Pad to ADC Input | LSB for an 8-Bit Conversion <sup>1</sup> (mV) | LSB for a 10-Bit Conversion <sup>1</sup> (mV) | LSB for a 12-Bit Conversion <sup>1</sup> (mV) | Full-Scale Voltage in 10-Bit Mode <sup>2</sup> | Range Name |
|-----------------------|----------------------------------|-----------------------------------------------|-----------------------------------------------|-----------------------------------------------|------------------------------------------------|------------|
| 000 <sup>3</sup>      | 0.15625                          | 64                                            | 16                                            | 4                                             | 16.368 V                                       | 16 V       |
| 001                   | 0.3125                           | 32                                            | 8                                             | 2                                             | 8.184 V                                        | 8 V        |
| 010 <sup>3</sup>      | 0.625                            | 16                                            | 4                                             | 1                                             | 4.092 V                                        | 4 V        |
| 011                   | 1.25                             | 8                                             | 2                                             | 0.5                                           | 2.046 V                                        | 2 V        |
| 100                   | 2.5                              | 4                                             | 1                                             | 0.25                                          | 1.023 V                                        | 1 V        |
| 101                   | 5.0                              | 2                                             | 0.5                                           | 0.125                                         | 0.5115 V                                       | 0.5 V      |
| 110                   | 10.0                             | 1                                             | 0.25                                          | 0.0625                                        | 0.25575 V                                      | 0.25 V     |
| 111                   | 20.0                             | 0.5                                           | 0.125                                         | 0.03125                                       | 0.127875 V                                     | 0.125 V    |

**Notes:**

1. LSB voltage equivalences assume  $V_{AREF} = 2.56$  V.
2. Full Scale voltage for  $n$ -bit mode:  $((2^n) - 1) \times (\text{LSB for a } n\text{-bit Conversion})$
3. These are the only valid ranges for the Temperature Monitor Block Prescaler.

Table 2-58 details the settings available to control the MUX within each of the AV, AC, and AT circuits. This MUX determines whether the signal routed to the ADC is the direct analog input, prescaled signal, or output of either the Current Monitor Block or the Temperature Monitor Block.

**Table 2-58 • Analog Multiplexer Truth Table—AV (x = 0), AC (x = 1), and AT (x = 3)**

| Control Lines Bx[4] | Control Lines Bx[3] | ADC Connected To                      |
|---------------------|---------------------|---------------------------------------|
| 0                   | 0                   | Prescaler                             |
| 0                   | 1                   | Direct input                          |
| 1                   | 0                   | Current amplifier temperature monitor |
| 1                   | 1                   | Not valid                             |

Table 2-59 details the settings available to control the Direct Analog Input switch for the AV, AC, and AT pins.

**Table 2-59 • Direct Analog Input Switch Control Truth Table—AV (x = 0), AC (x = 1), and AT (x = 3)**

| Control Lines Bx[5] | Direct Input Switch |
|---------------------|---------------------|
| 0                   | Off                 |
| 1                   | On                  |

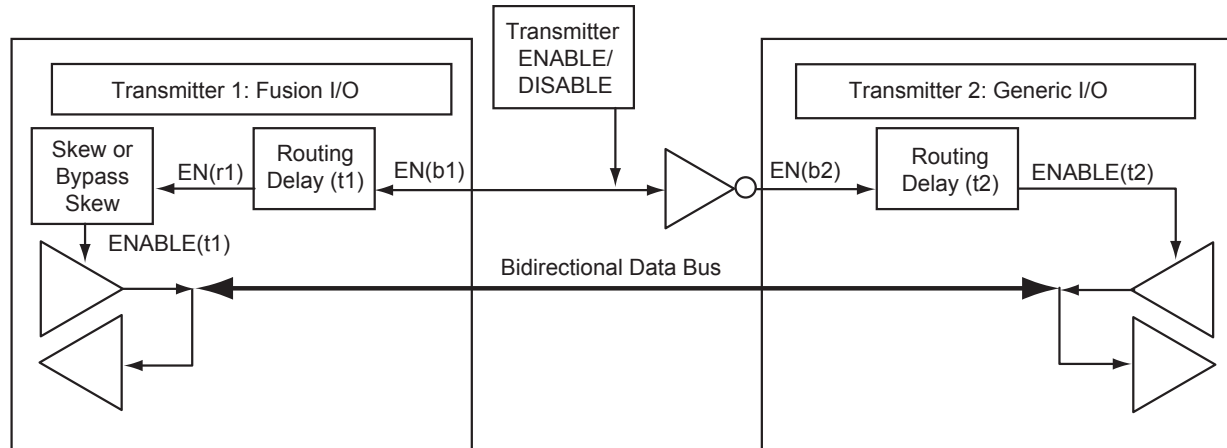
Table 2-60 details the settings available to control the polarity of the signals coming to the AV, AC, and AT pins. Note that the only valid setting for the AT pin is logic 0 to support positive voltages.

**Table 2-60 • Voltage Polarity Control Truth Table—AV (x = 0), AC (x = 1), and AT (x = 3)\***

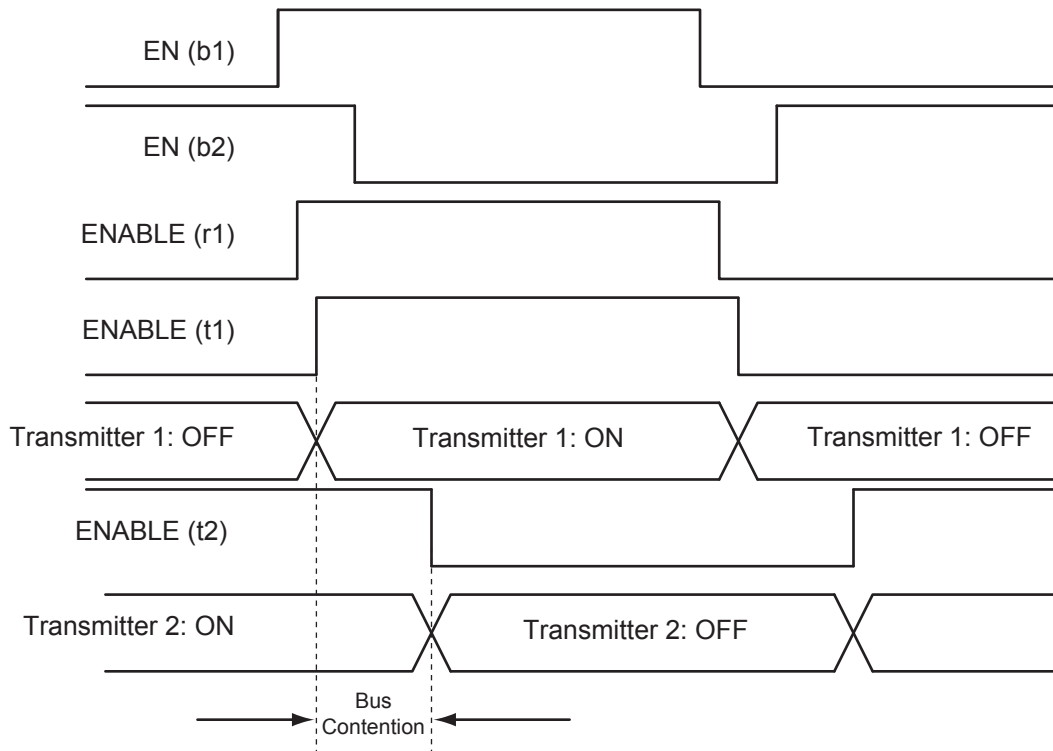
| Control Lines Bx[6] | Input Signal Polarity |
|---------------------|-----------------------|
| 0                   | Positive              |
| 1                   | Negative              |

**Note:** \*The B3[6] signal for the AT pad should be kept at logic 0 to accept only positive voltages.

At the system level, the skew circuit can be used in applications where transmission activities on bidirectional data lines need to be coordinated. This circuit, when selected, provides a timing margin that can prevent bus contention and subsequent data loss or transmitter overstress due to transmitter-to-transmitter current shorts. [Figure 2-110](#) presents an example of the skew circuit implementation in a bidirectional communication system. [Figure 2-111](#) shows how bus contention is created, and [Figure 2-112](#) on [page 2-151](#) shows how it can be avoided with the skew circuit.



**Figure 2-110 • Example of Implementation of Skew Circuits in Bidirectional Transmission Systems Using Fusion Devices**



**Figure 2-111 • Timing Diagram (bypasses skew circuit)**

### Timing Characteristics

**Table 2-128 • 1.5 V LVCMOS Low Slew**

Commercial Temperature Range Conditions:  $T_J = 70^\circ\text{C}$ , Worst-Case  $V_{CC} = 1.425\text{ V}$ ,  
Worst-Case  $V_{CCI} = 1.4\text{ V}$   
Applicable to Pro I/Os

| Drive Strength | Speed Grade | $t_{DOUT}$ | $t_{DP}$ | $t_{DIN}$ | $t_{PY}$ | $t_{PYS}$ | $t_{EOUT}$ | $t_{ZL}$ | $t_{ZH}$ | $t_{LZ}$ | $t_{HZ}$ | $t_{ZLS}$ | $t_{ZHS}$ | Units |
|----------------|-------------|------------|----------|-----------|----------|-----------|------------|----------|----------|----------|----------|-----------|-----------|-------|
| 2 mA           | Std.        | 0.66       | 14.11    | 0.04      | 1.70     | 2.14      | 0.43       | 14.37    | 13.14    | 3.40     | 2.68     | 16.61     | 15.37     | ns    |
|                | –1          | 0.56       | 12.00    | 0.04      | 1.44     | 1.82      | 0.36       | 12.22    | 11.17    | 2.90     | 2.28     | 14.13     | 13.08     | ns    |
|                | –2          | 0.49       | 10.54    | 0.03      | 1.27     | 1.60      | 0.32       | 10.73    | 9.81     | 2.54     | 2.00     | 12.40     | 11.48     | ns    |
| 4 mA           | Std.        | 0.66       | 11.23    | 0.04      | 1.70     | 2.14      | 0.43       | 11.44    | 9.87     | 3.77     | 3.36     | 13.68     | 12.10     | ns    |
|                | –1          | 0.56       | 9.55     | 0.04      | 1.44     | 1.82      | 0.36       | 9.73     | 8.39     | 3.21     | 2.86     | 11.63     | 10.29     | ns    |
|                | –2          | 0.49       | 8.39     | 0.03      | 1.27     | 1.60      | 0.32       | 8.54     | 7.37     | 2.81     | 2.51     | 10.21     | 9.04      | ns    |
| 8 mA           | Std.        | 0.66       | 10.45    | 0.04      | 1.70     | 2.14      | 0.43       | 10.65    | 9.24     | 3.84     | 3.55     | 12.88     | 11.48     | ns    |
|                | –1          | 0.56       | 8.89     | 0.04      | 1.44     | 1.82      | 0.36       | 9.06     | 7.86     | 3.27     | 3.02     | 10.96     | 9.76      | ns    |
|                | –2          | 0.49       | 7.81     | 0.03      | 1.27     | 1.60      | 0.32       | 7.95     | 6.90     | 2.87     | 2.65     | 9.62      | 8.57      | ns    |
| 12 mA          | Std.        | 0.66       | 10.02    | 0.04      | 1.70     | 2.14      | 0.43       | 10.20    | 9.23     | 3.97     | 4.22     | 12.44     | 11.47     | ns    |
|                | –1          | 0.56       | 8.52     | 0.04      | 1.44     | 1.82      | 0.36       | 8.68     | 7.85     | 3.38     | 3.59     | 10.58     | 9.75      | ns    |
|                | –2          | 0.49       | 7.48     | 0.03      | 1.27     | 1.60      | 0.32       | 7.62     | 6.89     | 2.97     | 3.15     | 9.29      | 8.56      | ns    |

*Note:* For the derating values at specific junction temperature and voltage supply levels, refer to [Table 3-7 on page 3-9](#).

**Table 2-129 • 1.5 V LVCMOS High Slew**

Commercial Temperature Range Conditions:  $T_J = 70^\circ\text{C}$ , Worst-Case  $V_{CC} = 1.425\text{ V}$ ,  
Worst-Case  $V_{CCI} = 1.4\text{ V}$   
Applicable to Pro I/Os

| Drive Strength | Speed Grade | $t_{DOUT}$ | $t_{DP}$ | $t_{DIN}$ | $t_{PY}$ | $t_{PYS}$ | $t_{EOUT}$ | $t_{ZL}$ | $t_{ZH}$ | $t_{LZ}$ | $t_{HZ}$ | $t_{ZLS}$ | $t_{ZHS}$ | Units |
|----------------|-------------|------------|----------|-----------|----------|-----------|------------|----------|----------|----------|----------|-----------|-----------|-------|
| 2 mA           | Std.        | 0.66       | 8.53     | 0.04      | 1.70     | 2.14      | 0.43       | 7.26     | 8.53     | 3.39     | 2.79     | 9.50      | 10.77     | ns    |
|                | –1          | 0.56       | 7.26     | 0.04      | 1.44     | 1.82      | 0.36       | 6.18     | 7.26     | 2.89     | 2.37     | 8.08      | 9.16      | ns    |
|                | –2          | 0.49       | 6.37     | 0.03      | 1.27     | 1.60      | 0.32       | 5.42     | 6.37     | 2.53     | 2.08     | 7.09      | 8.04      | ns    |
| 4 mA           | Std.        | 0.66       | 5.41     | 0.04      | 1.70     | 2.14      | 0.43       | 5.22     | 5.41     | 3.75     | 3.48     | 7.45      | 7.65      | ns    |
|                | –1          | 0.56       | 4.60     | 0.04      | 1.44     | 1.82      | 0.36       | 4.44     | 4.60     | 3.19     | 2.96     | 6.34      | 6.50      | ns    |
|                | –2          | 0.49       | 4.04     | 0.03      | 1.27     | 1.60      | 0.32       | 3.89     | 4.04     | 2.80     | 2.60     | 5.56      | 5.71      | ns    |
| 8 mA           | Std.        | 0.66       | 4.80     | 0.04      | 1.70     | 2.14      | 0.43       | 4.89     | 4.75     | 3.83     | 3.67     | 7.13      | 6.98      | ns    |
|                | –1          | 0.56       | 4.09     | 0.04      | 1.44     | 1.82      | 0.36       | 4.16     | 4.04     | 3.26     | 3.12     | 6.06      | 5.94      | ns    |
|                | –2          | 0.49       | 3.59     | 0.03      | 1.27     | 1.60      | 0.32       | 3.65     | 3.54     | 2.86     | 2.74     | 5.32      | 5.21      | ns    |
| 12 mA          | Std.        | 0.66       | 4.42     | 0.04      | 1.70     | 2.14      | 0.43       | 4.50     | 3.62     | 3.96     | 4.37     | 6.74      | 5.86      | ns    |
|                | –1          | 0.56       | 3.76     | 0.04      | 1.44     | 1.82      | 0.36       | 3.83     | 3.08     | 3.37     | 3.72     | 5.73      | 4.98      | ns    |
|                | –2          | 0.49       | 3.30     | 0.03      | 1.27     | 1.60      | 0.32       | 3.36     | 2.70     | 2.96     | 3.27     | 5.03      | 4.37      | ns    |

*Note:* For the derating values at specific junction temperature and voltage supply levels, refer to [Table 3-7 on page 3-9](#).

### SSTL3 Class II

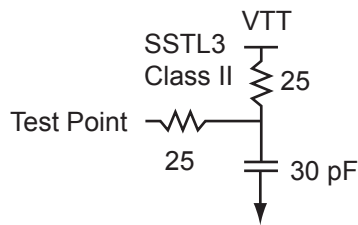
Stub-Speed Terminated Logic for 3.3 V memory bus standard (JESD8-8). Fusion devices support Class II. This provides a differential amplifier input buffer and a push-pull output buffer.

**Table 2-165 • Minimum and Maximum DC Input and Output Levels**

| SSTL3 Class II | VIL    |            | VIH        |        | VOL    | VOH        | IOL | IOH | IOSL                 | IOSH                 | IIL <sup>1</sup> | IIH <sup>2</sup> |
|----------------|--------|------------|------------|--------|--------|------------|-----|-----|----------------------|----------------------|------------------|------------------|
| Drive Strength | Min. V | Max. V     | Min. V     | Max. V | Max. V | Min. V     | mA  | mA  | Max. mA <sup>3</sup> | Max. mA <sup>3</sup> | μA <sup>4</sup>  | μA <sup>4</sup>  |
| 21 mA          | −0.3   | VREF − 0.2 | VREF + 0.2 | 3.6    | 0.5    | VCCI − 0.9 | 21  | 21  | 109                  | 103                  | 10               | 10               |

**Notes:**

1. IIL is the input leakage current per I/O pin over recommended operation conditions where  $-0.3\text{ V} < V_{IN} < V_{IL}$ .
2. IIH is the input leakage current per I/O pin over recommended operating conditions  $V_{IH} < V_{IN} < V_{CCI}$ . Input current is larger when operating outside recommended ranges.
3. Currents are measured at high temperature (100°C junction temperature) and maximum voltage.
4. Currents are measured at 85°C junction temperature.



**Figure 2-133 • AC Loading**

**Table 2-166 • AC Waveforms, Measuring Points, and Capacitive Loads**

| Input Low (V) | Input High (V) | Measuring Point* (V) | VREF (typ.) (V) | VTT (typ.) (V) | C <sub>LOAD</sub> (pF) |
|---------------|----------------|----------------------|-----------------|----------------|------------------------|
| VREF − 0.2    | VREF + 0.2     | 1.5                  | 1.5             | 1.485          | 30                     |

**Note:** \*Measuring point =  $V_{trip}$ . See Table 2-90 on page 2-166 for a complete table of trip points.

### Timing Characteristics

**Table 2-167 • SSTL3- Class II**

Commercial Temperature Range Conditions:  $T_J = 70^\circ\text{C}$ , Worst-Case VCC = 1.425 V, Worst-Case VCCI = 3.0 V, VREF = 1.5 V

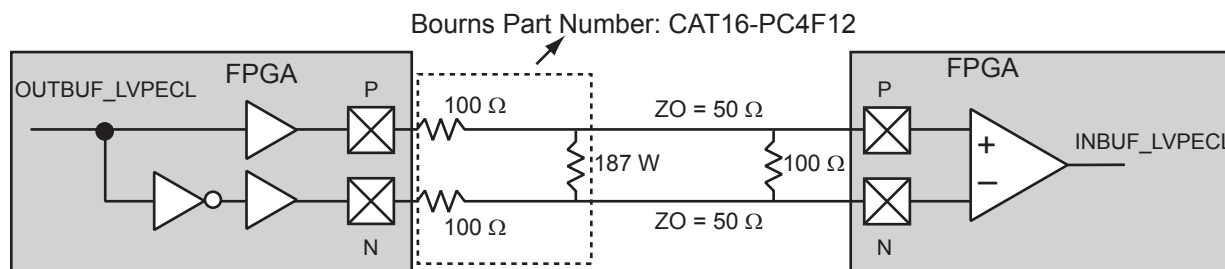
| Speed Grade | t <sub>DOUT</sub> | t <sub>DP</sub> | t <sub>DIN</sub> | t <sub>PY</sub> | t <sub>EOUT</sub> | t <sub>ZL</sub> | t <sub>ZH</sub> | t <sub>LZ</sub> | t <sub>HZ</sub> | t <sub>ZLS</sub> | t <sub>ZHS</sub> | Units |
|-------------|-------------------|-----------------|------------------|-----------------|-------------------|-----------------|-----------------|-----------------|-----------------|------------------|------------------|-------|
| Std.        | 0.66              | 2.07            | 0.04             | 1.25            | 0.43              | 2.10            | 1.67            |                 |                 | 4.34             | 3.91             | ns    |
| −1          | 0.56              | 1.76            | 0.04             | 1.06            | 0.36              | 1.79            | 1.42            |                 |                 | 3.69             | 3.32             | ns    |
| −2          | 0.49              | 1.54            | 0.03             | 0.93            | 0.32              | 1.57            | 1.25            |                 |                 | 3.24             | 2.92             | ns    |

**Note:** For the derating values at specific junction temperature and voltage supply levels, refer to Table 3-7 on page 3-9.

## LVPECL

Low-Voltage Positive Emitter-Coupled Logic (LVPECL) is another differential I/O standard. It requires that one data bit be carried through two signal lines. Like LVDS, two pins are needed. It also requires external resistor termination.

The full implementation of the LVDS transmitter and receiver is shown in an example in [Figure 2-136](#). The building blocks of the LVPECL transmitter–receiver are one transmitter macro, one receiver macro, three board resistors at the transmitter end, and one resistor at the receiver end. The values for the three driver resistors are different from those used in the LVDS implementation because the output standard specifications are different.



**Figure 2-136 • LVPECL Circuit Diagram and Board-Level Implementation**

**Table 2-171 • Minimum and Maximum DC Input and Output Levels**

| DC Parameter | Description                    | Min.  | Max. | Min.  | Max. | Min.  | Max. | Units |
|--------------|--------------------------------|-------|------|-------|------|-------|------|-------|
| VCCI         | Supply Voltage                 | 3.0   |      | 3.3   |      | 3.6   |      | V     |
| VOL          | Output Low Voltage             | 0.96  | 1.27 | 1.06  | 1.43 | 1.30  | 1.57 | V     |
| VOH          | Output High Voltage            | 1.8   | 2.11 | 1.92  | 2.28 | 2.13  | 2.41 | V     |
| VIL, VIH     | Input Low, Input High Voltages | 0     | 3.6  | 0     | 3.6  | 0     | 3.6  | V     |
| VODIFF       | Differential Output Voltage    | 0.625 | 0.97 | 0.625 | 0.97 | 0.625 | 0.97 | V     |
| VOCM         | Output Common Mode Voltage     | 1.762 | 1.98 | 1.762 | 1.98 | 1.762 | 1.98 | V     |
| VICM         | Input Common Mode Voltage      | 1.01  | 2.57 | 1.01  | 2.57 | 1.01  | 2.57 | V     |
| VIDIFF       | Input Differential Voltage     | 300   |      | 300   |      | 300   |      | mV    |

**Table 2-172 • AC Waveforms, Measuring Points, and Capacitive Loads**

| Input Low (V) | Input High (V) | Measuring Point* (V) | VREF (typ.) (V) |
|---------------|----------------|----------------------|-----------------|
| 1.64          | 1.94           | Cross point          | –               |

*Note:* \*Measuring point =  $V_{trip}$ . See [Table 2-90 on page 2-166](#) for a complete table of trip points.

## Timing Characteristics

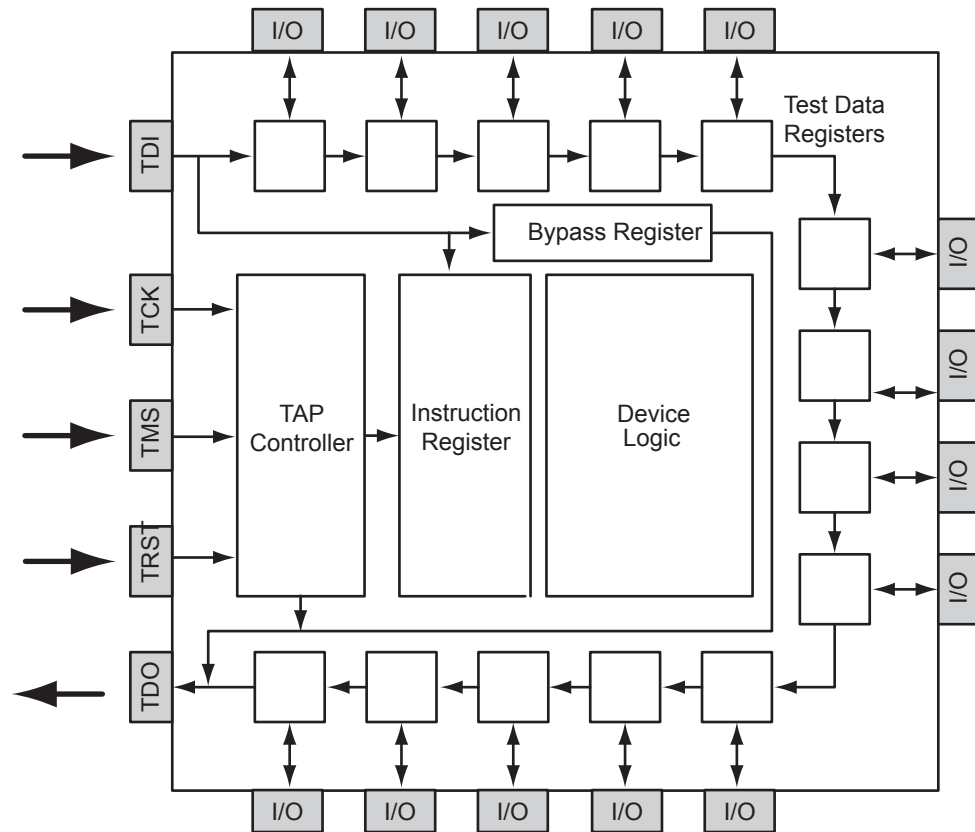
**Table 2-173 • LVPECL**

Commercial Temperature Range Conditions:  $T_J = 70^\circ\text{C}$ , Worst-Case VCC = 1.425 V,  
Worst-Case VCCI = 3.0 V  
Applicable to Pro I/Os

| Speed Grade | $t_{DOUT}$ | $t_{DP}$ | $t_{DIN}$ | $t_{PY}$ | Units |
|-------------|------------|----------|-----------|----------|-------|
| Std.        | 0.66       | 2.14     | 0.04      | 1.63     | ns    |
| –1          | 0.56       | 1.82     | 0.04      | 1.39     | ns    |
| –2          | 0.49       | 1.60     | 0.03      | 1.22     | ns    |

*Note:* For the derating values at specific junction temperature and voltage supply levels, refer to [Table 3-7 on page 3-9](#).

connected to the internal core logic I/O tile and the input, output, and control ports of an I/O buffer to capture and load data into the register to control or observe the logic state of each I/O.



**Figure 2-146 • Boundary Scan Chain in Fusion**

**Table 2-185 • Boundary Scan Opcodes**

|                | Hex Opcode |
|----------------|------------|
| EXTEST         | 00         |
| HIGHZ          | 07         |
| USERCODE       | 0E         |
| SAMPLE/PRELOAD | 01         |
| IDCODE         | 0F         |
| CLAMP          | 05         |
| BYPASS         | FF         |

The 1.76 W power is less than the required 3.00 W. The design therefore requires a heat sink, or the airflow where the device is mounted should be increased. The design's total junction-to-air thermal resistance requirement can be estimated by EQ 7:

$$\theta_{ja(\text{total})} = \frac{T_J - T_A}{P} = \frac{100^\circ\text{C} - 70^\circ\text{C}}{3.00\text{ W}} = 10.00^\circ\text{C/W}$$

EQ 7

Determining the heat sink's thermal performance proceeds as follows:

$$\theta_{JA(\text{TOTAL})} = \theta_{JC} + \theta_{CS} + \theta_{SA}$$

EQ 8

where

$$\theta_{JA} = 0.37^\circ\text{C/W}$$

= Thermal resistance of the interface material between the case and the heat sink, usually provided by the thermal interface manufacturer

$$\theta_{SA} = \text{Thermal resistance of the heat sink in } ^\circ\text{C/W}$$

$$\theta_{SA} = \theta_{JA(\text{TOTAL})} - \theta_{JC} - \theta_{CS}$$

EQ 9

$$\theta_{SA} = 13.33^\circ\text{C/W} - 8.28^\circ\text{C/W} - 0.37^\circ\text{C/W} = 5.01^\circ\text{C/W}$$

A heat sink with a thermal resistance of 5.01°C/W or better should be used. Thermal resistance of heat sinks is a function of airflow. The heat sink performance can be significantly improved with increased airflow.

Carefully estimating thermal resistance is important in the long-term reliability of an Microsemi FPGA. Design engineers should always correlate the power consumption of the device with the maximum allowable power dissipation of the package selected for that device.

Note: The junction-to-air and junction-to-board thermal resistances are based on JEDEC standard (JESD-51) and assumptions made in building the model. It may not be realized in actual application and therefore should be used with a degree of caution. Junction-to-case thermal resistance assumes that all power is dissipated through the case.

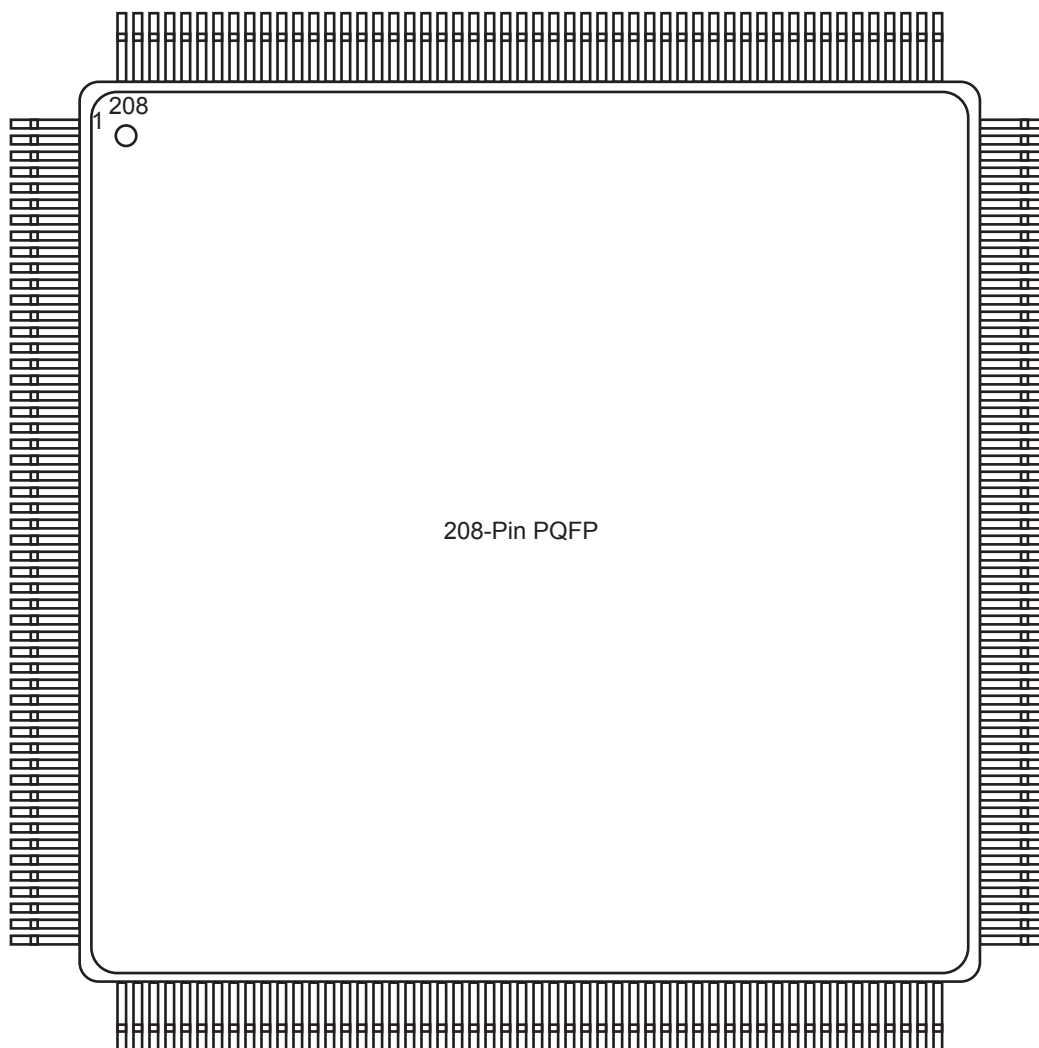
## Temperature and Voltage Derating Factors

**Table 3-7 • Temperature and Voltage Derating Factors for Timing Delays**  
(normalized to  $T_J = 70^\circ\text{C}$ , Worst-Case VCC = 1.425 V)

| Array Voltage<br>VCC (V) | Junction Temperature ( $^\circ\text{C}$ ) |                   |                    |                    |                    |                     |
|--------------------------|-------------------------------------------|-------------------|--------------------|--------------------|--------------------|---------------------|
|                          | $-40^\circ\text{C}$                       | $0^\circ\text{C}$ | $25^\circ\text{C}$ | $70^\circ\text{C}$ | $85^\circ\text{C}$ | $100^\circ\text{C}$ |
| 1.425                    | 0.88                                      | 0.93              | 0.95               | 1.00               | 1.02               | 1.05                |
| 1.500                    | 0.83                                      | 0.88              | 0.90               | 0.95               | 0.96               | 0.99                |
| 1.575                    | 0.80                                      | 0.85              | 0.87               | 0.91               | 0.93               | 0.96                |

## PQ208

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### Note

For Package Manufacturing and Environmental information, visit the Resource Center at <http://www.microsemi.com/soc/products/solutions/package/default.aspx>.

| FG676      |                  |
|------------|------------------|
| Pin Number | AFS1500 Function |
| G13        | IO22NDB1V0       |
| G14        | IO22PDB1V0       |
| G15        | GND              |
| G16        | IO32PPB1V1       |
| G17        | IO36NPB1V2       |
| G18        | VCCIB1           |
| G19        | GND              |
| G20        | IO47NPB2V0       |
| G21        | IO49PDB2V0       |
| G22        | VCCIB2           |
| G23        | IO46NDB2V0       |
| G24        | GBC2/IO46PDB2V0  |
| G25        | IO48NPB2V0       |
| G26        | NC               |
| H1         | GND              |
| H2         | NC               |
| H3         | IO118NDB4V0      |
| H4         | IO118PDB4V0      |
| H5         | IO119NPB4V0      |
| H6         | IO124NDB4V0      |
| H7         | GND              |
| H8         | VCOMPLA          |
| H9         | VCCPLA           |
| H10        | VCCIB0           |
| H11        | IO12NDB0V1       |
| H12        | IO12PDB0V1       |
| H13        | VCCIB0           |
| H14        | VCCIB1           |
| H15        | IO30NDB1V1       |
| H16        | IO30PDB1V1       |
| H17        | VCCIB1           |
| H18        | IO36PPB1V2       |
| H19        | IO38NPB1V2       |
| H20        | GND              |
| H21        | IO49NDB2V0       |
| H22        | IO50PDB2V0       |

| FG676      |                  |
|------------|------------------|
| Pin Number | AFS1500 Function |
| H23        | IO50NDB2V0       |
| H24        | IO51PDB2V0       |
| H25        | NC               |
| H26        | GND              |
| J1         | NC               |
| J2         | VCCIB4           |
| J3         | IO115PDB4V0      |
| J4         | GND              |
| J5         | IO116NDB4V0      |
| J6         | IO116PDB4V0      |
| J7         | VCCIB4           |
| J8         | IO117PDB4V0      |
| J9         | VCCIB4           |
| J10        | GND              |
| J11        | IO06NDB0V1       |
| J12        | IO06PDB0V1       |
| J13        | IO16NDB0V2       |
| J14        | IO16PDB0V2       |
| J15        | IO28NDB1V1       |
| J16        | IO28PDB1V1       |
| J17        | GND              |
| J18        | IO38PPB1V2       |
| J19        | IO53PDB2V0       |
| J20        | VCCIB2           |
| J21        | IO52PDB2V0       |
| J22        | IO52NDB2V0       |
| J23        | GND              |
| J24        | IO51NDB2V0       |
| J25        | VCCIB2           |
| J26        | NC               |
| K1         | NC               |
| K2         | NC               |
| K3         | IO115NDB4V0      |
| K4         | IO113PDB4V0      |
| K5         | VCCIB4           |
| K6         | IO114NDB4V0      |

| FG676      |                  |
|------------|------------------|
| Pin Number | AFS1500 Function |
| K7         | IO114PDB4V0      |
| K8         | IO117NDB4V0      |
| K9         | GND              |
| K10        | VCC              |
| K11        | VCCIB0           |
| K12        | GND              |
| K13        | VCCIB0           |
| K14        | VCCIB1           |
| K15        | GND              |
| K16        | VCCIB1           |
| K17        | GND              |
| K18        | GND              |
| K19        | IO53NDB2V0       |
| K20        | IO57PDB2V0       |
| K21        | GCA2/IO59PDB2V0  |
| K22        | VCCIB2           |
| K23        | IO54NDB2V0       |
| K24        | IO54PDB2V0       |
| K25        | NC               |
| K26        | NC               |
| L1         | GND              |
| L2         | NC               |
| L3         | IO112PPB4V0      |
| L4         | IO113NDB4V0      |
| L5         | GFB2/IO109PDB4V0 |
| L6         | GFA2/IO110PDB4V0 |
| L7         | IO112NPB4V0      |
| L8         | IO104PDB4V0      |
| L9         | IO111PDB4V0      |
| L10        | VCCIB4           |
| L11        | GND              |
| L12        | VCC              |
| L13        | GND              |
| L14        | VCC              |
| L15        | GND              |
| L16        | VCC              |